JJMICROELECTRONICS

60V, 40A, 14.6m Ω N-channel Power Trench MOSFET

JMTG170N06A

Features

- Excellent $R_{\text{DS(ON)}}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant
- Pb-free plating

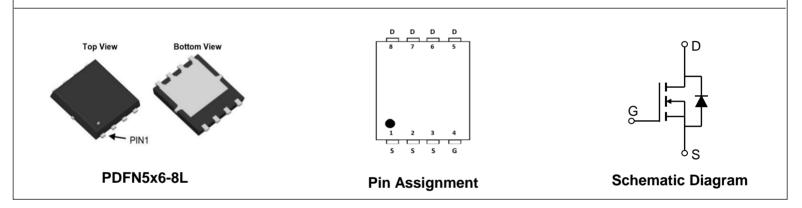
Applications

- Load Switch
- PWM Application
- Power Management

Product Summary

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Parameters	Value	Unit
V _{DSS}	60	V
V _{GS(th)_Typ}	1.5	V
I _D (@V _{GS} =10V)	40	А
R _{DS(ON)_Typ} (@V _{GS} =10V	12.6	mΩ
R _{DS(ON)_Typ} (@V _{GS} =4.5V	14.6	mΩ





Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMTG170N06A	G170N06A	1	Tape&Reel	PDFN5x6-8L	5000	50000

Absolute Maximum Ratings (@ $T_c = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter		Value	Unit
V _{DS}	Drain-to-Source Voltage		60	V
V_{GS}	Gate-to-Source Voltage		±20	V
1-	Continuous Drain Current	$T_{C} = 25^{\circ}C$	40	A
Ι _D		$T_{\rm C} = 100^{\circ}{\rm C}$	28	A
I _{DM}	Pulsed Drain Current ⁽¹⁾		Refer to Fig.4	A
E _{AS}	Single Pulsed Avalanche Energ	Single Pulsed Avalanche Energy ⁽²⁾		mJ
P _D	Power Discipation	T _C = 25°C	113	w
' D		$T_{c} = 100^{\circ}C$	45	vv
T _J , T _{STG}	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Мах	Unit
R_{\thetaJA}	Thermal Resistance, Junction to Ambient ⁽³⁾	42	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.1	C/ VV

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	l aracteristics					
V _{(BR)DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 60V, V_{GS} = 0V$	-	-	1.0	μA
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics			•	-	-
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.1	1.5	2.5	V
D	Static Drain Course ON Desister as (4)	$V_{GS} = 10V, I_D = 30A$	-	12.6	15	mΩ
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 4.5 V, I_{D} = 20 A$	-	14.6	21	mΩ
Dynami	ic Characteristics					
R_g	Gate Resistance	f = 1MHz	-	2.3	-	Ω
C _{iss}	Input Capacitance		-	2637	-	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 30V,$ f = 1MHz	-	122	-	pF
C _{rss}	Reverse Transfer Capacitance		-	98	-	pF
Qg	Total Gate Charge	N/ 0/ 40V/	-	49	-	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 30V, I_{D} = 30A$	-	10	-	nC
Q_{gd}	Gate Drain("Miller") Charge	V _{DS} = 00 V, I <u>D</u> = 00/V	-	9	-	nC
Switchi	ing Characteristics			1		
t _{d(on)}	Turn-On DelayTime	4	-	9	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 30V$	-	28	-	ns
t _{d(off)}	Turn-Off DelayTime	I_D = 30A, R_{GEN} = 3 Ω	-	44	-	ns
t _f	Turn-Off Fall Time		-	7	-	ns
Body D	iode Characteristics			T	T	
I _S	Maximum Continuous Body Diode Forward Current			-	40	А
I _{SM}	Maximum Pulsed Body Diode Forward Current		-	-	160	А
$\rm V_{SD}$	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 30A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	I _F = 30A, di/dt = 100A/us	-	21	-	ns
Qrr	Body Diode Reverse Recovery Charge	$r_{\rm F} = 30\pi, {\rm u}/{\rm u}{\rm I} = 100\pi/{\rm u}{\rm S}$	-	21	-	nC

Electrical Characteristics ($T_J = 25^{\circ}C$ unless otherwise specified)

Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

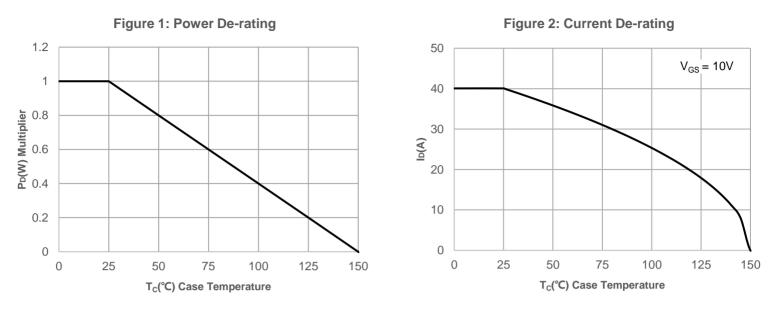
2. E_{AS} condition: Starting T_J =25C, V_{DD} =30V, V_G =10V, R_G =25ohm, L=0.5mH, I_{AS} =16A, V_{DD} =0V during time in avalanche.

3. $R_{\theta JA}$ is measured with the device mounted on a 1inch 2 pad of 2oz copper FR4 PCB.

4. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 0.5%.







Typical Performance Characteristics



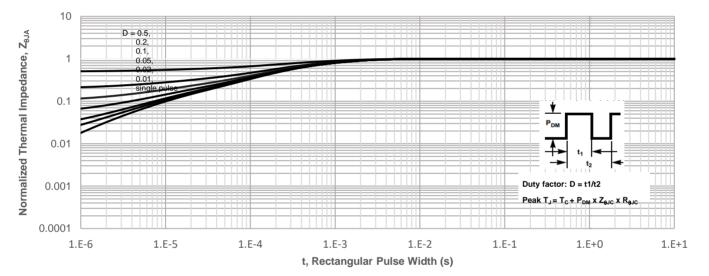
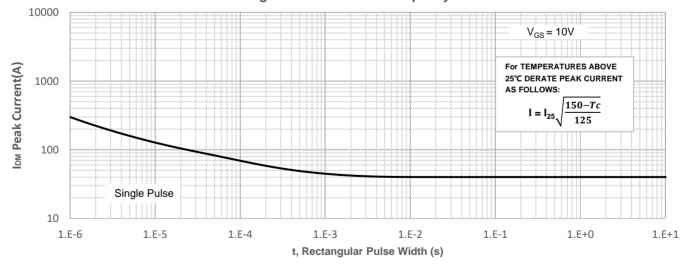
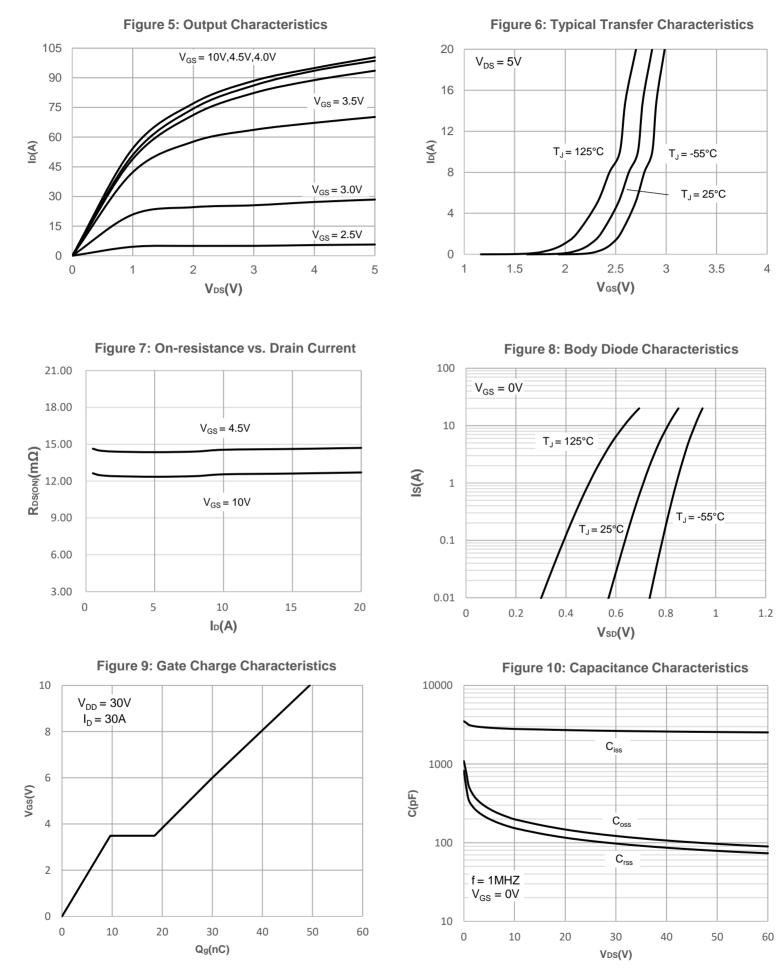


Figure 4: Peak Current Capacity





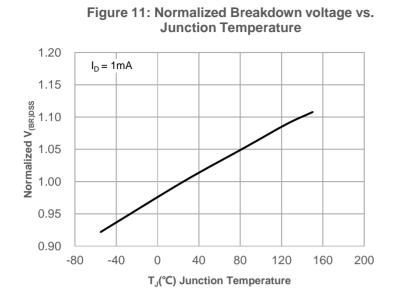
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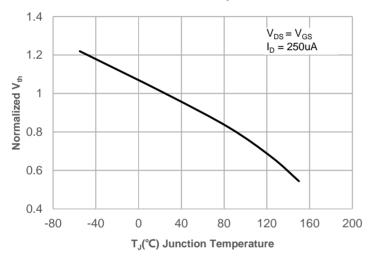
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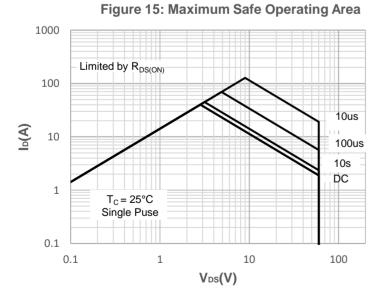
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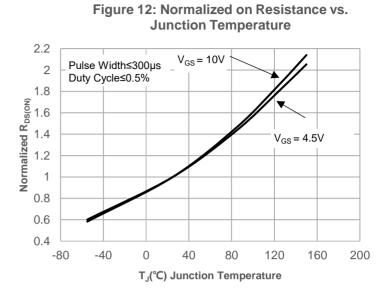




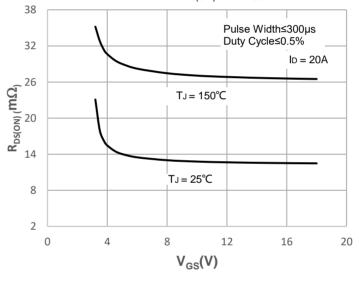














Test Circuit

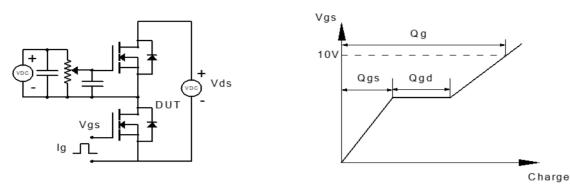


Figure 1: Gate Charge Test Circuit & Waveform

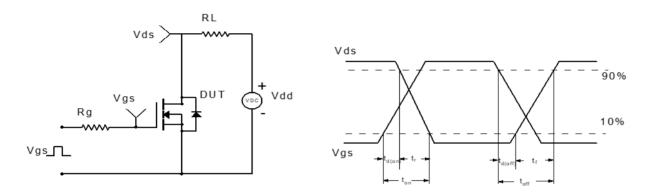


Figure 2: Resistive Switching Test Circuit & Waveform

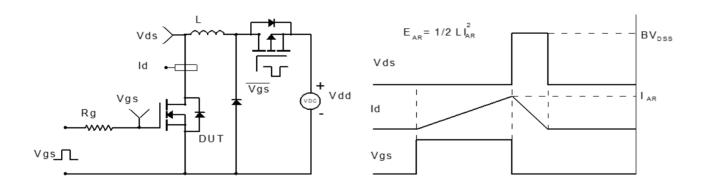


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

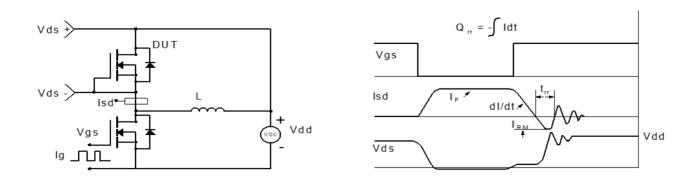
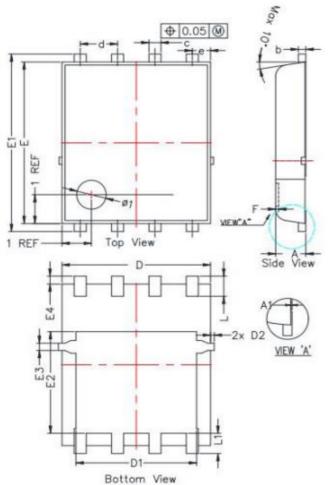


Figure 4: Diode Recovery Test Circuit & Waveform





Package Mechanical Data(PDFN5x6-8L)

CHANDON C	DIMENSION IN MM			DIMENSION IN INCHES			
SYMBOLS	MIN	NOM	MAX	MIN	NOM	MAX	
* A	0.900	1.000	1.100	0.035	0.039	0.043	
A1	0.000		0.050	0.000		0.002	
b	0.246	0.254	0.312	0.010	0.010	0.012	
* c	0.310	0.410	0.510	0.012	0.016	0.020	
d		1.27 BSC		0.050 BSC			
* D	4.950	5.050	5.150	0.195	0.199	0.203	
D1	4.000	4.100	4.200	0.157	0.161	0.165	
* D2			0.125	***	***	0.005	
е		0.62 BSC		0.024 BSC			
* E	5.500	5.600	5.700	0.217	0.220	0.224	
* E1	6.050	6.150	6.250	0.238	0.242	0.246	
E2	3.425	3.525	3.625	0.135	0.139	0.143	
E3	0.150	0.250	0.350	0.006	0.010	0.014	
* E4	0.175	0.275	0.375	0.007	0.011	0.015	
F	-	-	0.100	-	-	0.004	
۰.	0.500	0.600	0.700	0.02	0.02	0.03	
L1	0.600	0.700	0.800	0.02	0.03	0.03	

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